



P-CHANNEL ENHANCEMENT MODE MOSFET

Product Summary

V _{(BR)DSS}	R _{DS(on)}	Ι _D Τ _A = +25°C
	700m $Ω$ @ V _{GS} = -4.5V	-460mA
-20V	900mΩ @ $V_{GS} = -2.5V$	-420mA
	1300mΩ @ V _{GS} = -1.8V	-350mA

Features and Benefits

- Low On-Resistance
- Low Gate Threshold Voltage
- Low Input Capacitance
- Fast Switching Speed
- Low Input/Output Leakage
- ESD Protected Up To 3kV
- Totally Lead-Free & Fully RoHS compliant (Notes 1 & 2)
- Halogen and Antimony Free. "Green" Device (Note 3)
- Qualified to AEC-Q101 standards for High Reliability

Description and Applications

This new generation MOSFET is designed to minimize the on-state resistance (R_{DS(on)}) and yet maintain superior switching performance, making it ideal for high efficiency power management applications.

- DC-DC Converters
- Load Switch
- Power Management Functions

Mechanical Data

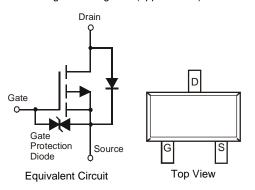
- Case: SOT523
- Case Material: Molded Plastic, "Green" Molding Compound.
 UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminals: Finish Matte Tin annealed over Alloy 42 leadframe. Solderable per MIL-STD-202, Method 208
- Terminal Connections: See Diagram
- Weight: 0.002 grams (approximate)





SOT523

Top View



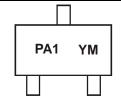
Ordering Information (Note 3)

Part Number	Case	Packaging	
DMG1013T-7	SOT523	3000/Tape & Reel	

Notes:

- 1. No purposely added lead. Fully EU Directive 2002/95/EC (RoHS) & 2011/65/EU (RoHS 2) compliant.
- 2. See http://www.diodes.com/quality/lead_free.htmlfor more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free.
- 3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.
- 4. For packaging details, go to our website at http://www.diodes.com/products/packages.html.

Marking Information



PA1 = Product Type Marking Code YM = Date Code Marking Y = Year (ex: W = 2009) M = Month (ex: 9 = September)

Date Code Kev

Year	2009	20	10	2011	2012	20	13	2014	2015	20	16	2017
Code	W)	Χ	Υ	Z		A	В	С)	Е
Month	Jan	Feb	Mar	Apr	May	Jun	Jul	Aug	Sep	Oct	Nov	Dec
Code	1	2	3	4	5	6	7	8	9	0	N	D



Maximum Ratings @T_A = +25°C unless otherwise specified

Charac	teristic		Symbol	Value	Units
Drain-Source Voltage			V_{DSS}	-20	V
Gate-Source Voltage			V_{GSS}	±6	V
Drain Current (Note 5) Steady $T_A = +25^{\circ}C$ State $T_A = +85^{\circ}C$			I _D	-0.46 -0.33	А
Pulsed Drain Current (Note 6)			I _{DM}	-6	A

Thermal Characteristics @TA = +25°C unless otherwise specified

Characteristic	Symbol	Value	Units
Total Power Dissipation (Note 5)	P_{D}	0.27	W
Thermal Resistance, Junction to Ambient (Note 5)	$R_{ hetaJA}$	461	°C/W
Operating and Storage Temperature Range	$T_{J,}T_{STG}$	-55 to +150	°C

Electrical Characteristics @TA = +25°C unless otherwise specified

Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition	
OFF CHARACTERISTICS (Note 7)							
Drain-Source Breakdown Voltage	BV _{DSS}	-20	-	1	V	$V_{GS} = 0V, I_D = -250\mu A$	
Zero Gate Voltage Drain Current T _J = +25°C	I _{DSS}	ı	-	-100	nA	$V_{DS} = -20V, V_{GS} = 0V$	
Gate-Source Leakage	I _{GSS}	-	-	±2.0	μΑ	$V_{GS} = \pm 4.5V, V_{DS} = 0V$	
ON CHARACTERISTICS (Note 7)							
Gate Threshold Voltage	$V_{GS(th)}$	-0.5	-	-1.0	V	$V_{DS} = V_{GS}, I_{D} = -250 \mu A$	
			0.5	0.7		$V_{GS} = -4.5V$, $I_D = -350mA$	
Static Drain-Source On-Resistance	R _{DS} (ON)	-	0.7	0.9	Ω	$V_{GS} = -2.5V$, $I_{D} = -300mA$	
			1.0	1.3		$V_{GS} = -1.8V, I_D = -150mA$	
Forward Transfer Admittance	Y _{fs}	-	0.9	-	S	$V_{DS} = -10V, I_{D} = -250mA$	
Diode Forward Voltage	V_{SD}		-0.8	-1.2	V	$V_{GS} = 0V, I_{S} = -150mA$	
DYNAMIC CHARACTERISTICS (Note 8)							
Input Capacitance	C _{iss}	ı	59.76	1	рF	101/11/101/	
Output Capacitance	Coss	ı	12.07	-	pF	$V_{DS} = -16V, V_{GS} = 0V,$ -f = 1.0MHz	
Reverse Transfer Capacitance	Crss	•	6.36	-	pF	T = T.OIVII IZ	
Total Gate Charge	Qg	-	580	-	рC	\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\	
Gate-Source Charge	Q_{gs}	-	104	-	рC	$V_{GS} = -4.5V, V_{DS} = -10V,$	
Gate-Drain Charge	Q _{gd}	-	125	-	рC	$I_D = -250 \text{mA}$	
Turn-On Delay Time	t _{D(on)}	-	5.1	-	ns	10)/)/ 45)/	
Turn-On Rise Time	t _r	-	8.1	-	ns	$V_{DD} = -10V, V_{GS} = -4.5V,$	
Turn-Off Delay Time	t _{D(off)}	-	28.4	-	ns	$R_L = 47\Omega, R_G = 10\Omega,$ $I_D = -200 \text{mA}$	
Turn-Off Fall Time	t _f	-	20.7	-	ns	71D = -20011IA	

Notes:

- 5. For a device surface mounted on a minimum recommended pad layout of an FR4 PCB, in still air conditions; the device is measured when operating in steady-state condition.
- 6. Same as note 5, except the device is pulsed at duty cycle of 1% for a pulse width of 10 μ s.
- 7. Measured under pulsed conditions to minimize self-heating effect. Pulse width $\leq 300 \mu s$; duty cycle $\leq 2\%$.
- 8. For design aid only, not subject to production testing.



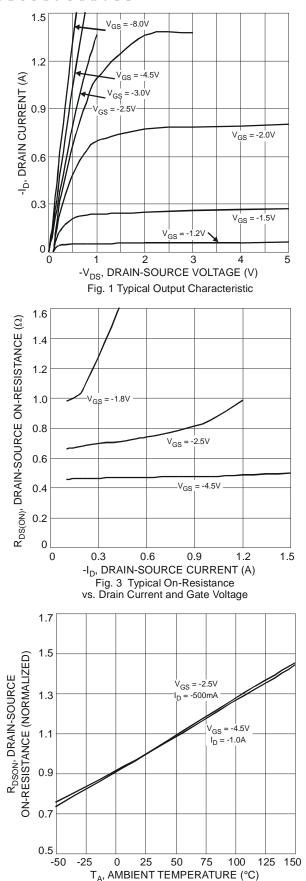
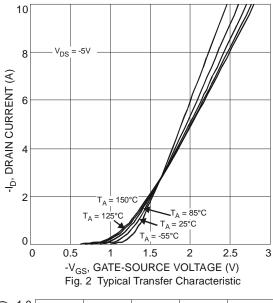
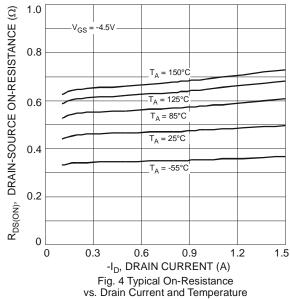
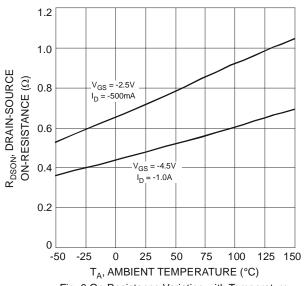


Fig. 5 On-Resistance Variation with Temperature







1.2



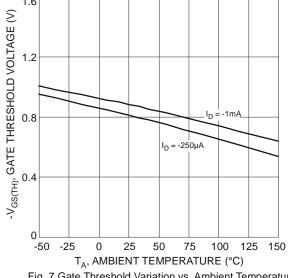
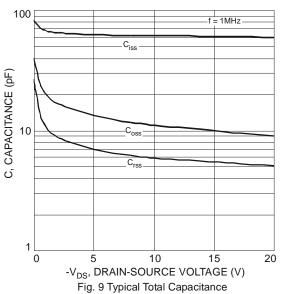


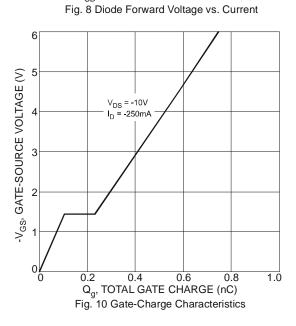
Fig. 7 Gate Threshold Variation vs. Ambient Temperature



-I_S, SOURCE CURRENT (A) A = 25°C 2 0 $\begin{array}{cccc} 0.4 & 0.6 & 0.8 & 1.0 \\ \text{-V}_{\text{SD}}, \, \text{SOURCE-DRAIN VOLTAGE (V)} \end{array}$ 0.2

10

8



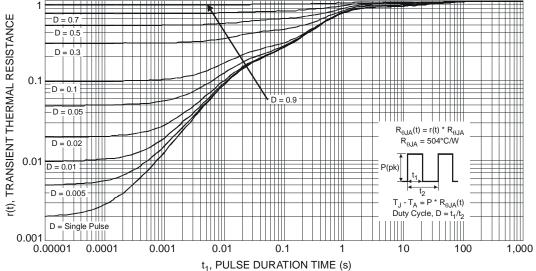
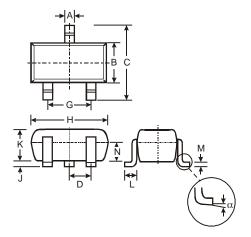


Fig. 11 Transient Thermal Response



Package Outline Dimensions

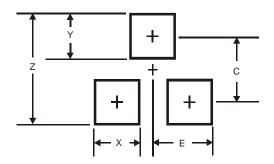
Please see AP02002 at http://www.diodes.com/datasheets/ap02002.pdf for latest version.



	SOT523							
Dim	Min	Max	Тур					
Α	0.15	0.30	0.22					
В	0.75	0.85	0.80					
С	1.45	1.75	1.60					
D		_	0.50					
G	0.90	1.10	1.00					
Н	1.50	1.70	1.60					
J	0.00	0.10	0.05					
K	0.60	0.80	0.75					
L	0.10	0.30	0.22					
М	0.10	0.20	0.12					
N	0.45	0.65	0.50					
α	0°	8°	_					
All	All Dimensions in mm							

Suggested Pad Layout

Please see AP02001 at http://www.diodes.com/datasheets/ap02001.pdf for latest version.



Dimensions	Value (in mm)
Z	1.8
Х	0.4
Y	0.51
С	1.3
Е	0.7



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